

## Announcements

1. Reworked exam 3 – due today; solutions will be posted
2. Topics for today –

Review of wave properties of EM radiation

Notion of interference phenomena

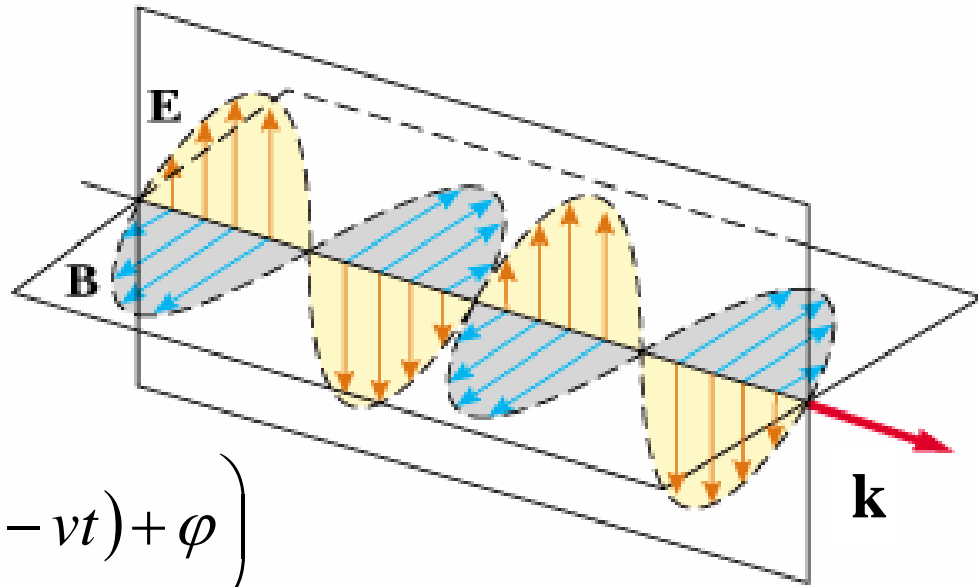
Young's double slit interference

Thin film interference effects

Michelson's interferometer

## Wave phenomena associated with light

Plane polarized  
electromagnetic wave  
at an instant of time:



$$E_y(x, t) = E_{\max} \sin\left(\frac{2\pi}{\lambda}(x - vt) + \varphi\right)$$

Superposition of light waves:  $E_y^{tot}(x, t) = E_y^1(x, t) + E_y^2(x, t)$

$$\begin{aligned} \text{Example } E_y(x, t) &= E_{\max} \sin\left(\frac{2\pi}{\lambda}(x - vt)\right) + E_{\max} \sin\left(\frac{2\pi}{\lambda}(x - vt) + \varphi\right) \\ &= 2E_{\max} \sin\left(\frac{2\pi}{\lambda}(x - vt) + \frac{1}{2}\varphi\right) \cos\left(\frac{\varphi}{2}\right) \end{aligned}$$

Some details:

$$\begin{aligned}E_y^{tot}(x,t) &= E_y^1(x,t) + E_y^2(x,t) \\E_y(x,t) &= E_{\max} \sin\left(\frac{2\pi}{\lambda}(x-vt)\right) + E_{\max} \sin\left(\frac{2\pi}{\lambda}(x-vt) + \varphi\right) \\&= 2E_{\max} \sin\left(\frac{2\pi}{\lambda}(x-vt) + \frac{1}{2}\varphi\right) \cos\left(\frac{\varphi}{2}\right)\end{aligned}$$

Note that this result follows from the trigonometric identity:

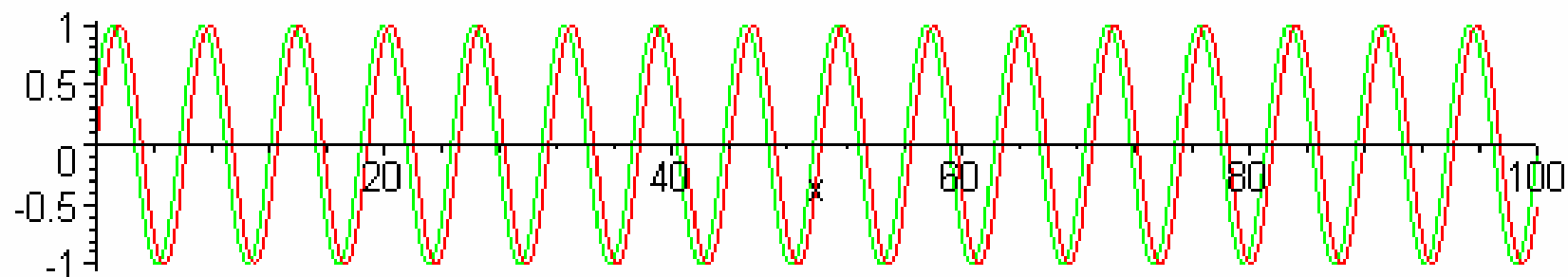
$$\sin(A) + \sin(B) = 2 \sin\left(\frac{A+B}{2}\right) \cos\left(\frac{A-B}{2}\right)$$

Intensity :

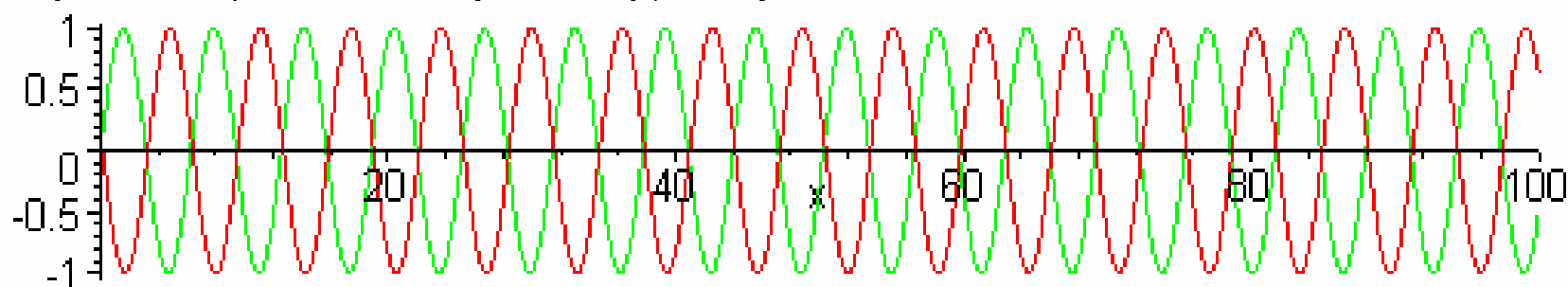
$$I^1 = \frac{1}{2c\mu_0} |E_{\max}|^2 = I^2$$

$$I^{tot} = \frac{4}{2c\mu_0} \left| E_{\max} \cos\left(\frac{\varphi}{2}\right) \right|^2 = 4I^1 \cos^2\left(\frac{\varphi}{2}\right)$$

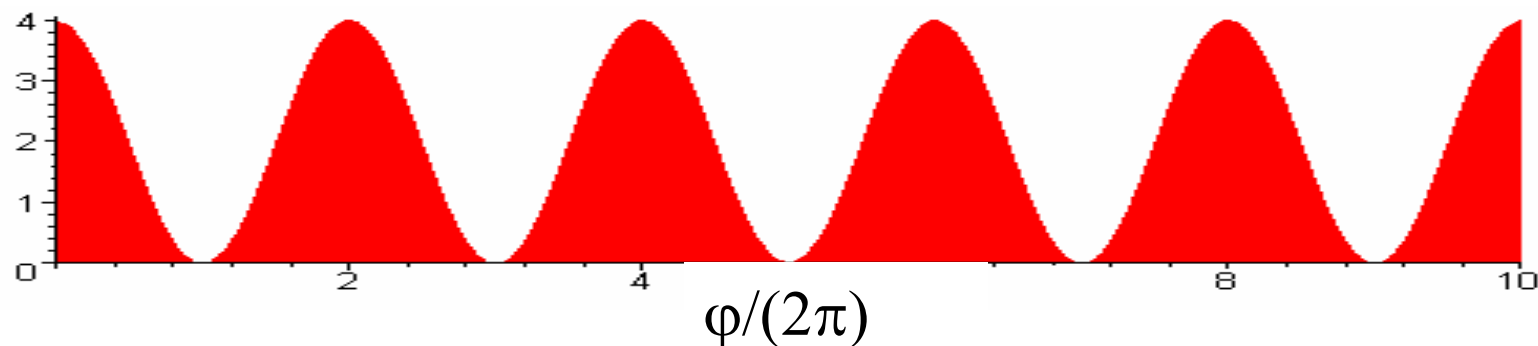
Example:  $\phi=0.5$  rad -- plotting snapshot of EM wave



Example:  $\phi=3$  rad -- plotting snapshot of EM wave



Intensity as a function of  $\phi$ :

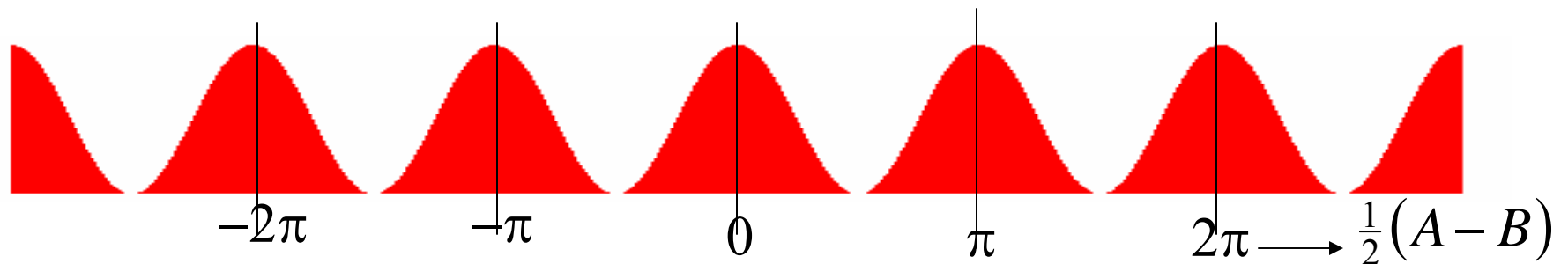


Review of interference phenomena – Occurs when there are two or more electromagnetic waves which combine at a give point  $P$ .

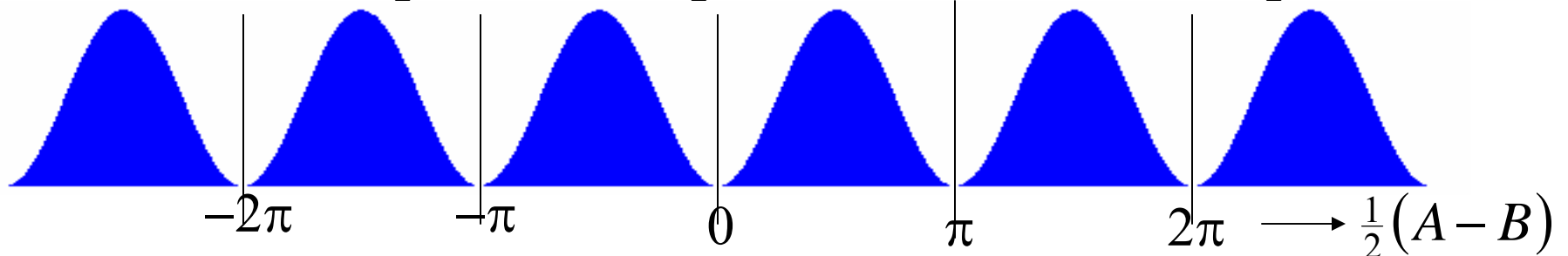
$$E(P, t) = E_{\max} \sin\left(\frac{2\pi r_1}{\lambda} - 2\pi f t\right) \pm E_{\max} \sin\left(\frac{2\pi r_2}{\lambda} - 2\pi f t\right)$$

Trig identity :

$$\sin A + \sin B = 2 \sin\left(\frac{1}{2}(A + B)\right) \cos\left(\frac{1}{2}(A - B)\right) \Rightarrow I = I_{\max} \left\{ \cos\left(\frac{1}{2}(A - B)\right) \right\}^2$$

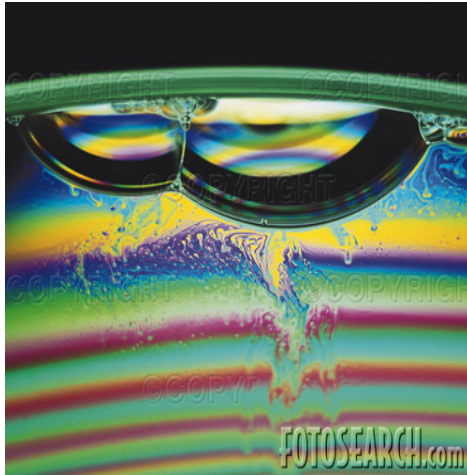


$$\sin A - \sin B = 2 \cos\left(\frac{1}{2}(A + B)\right) \sin\left(\frac{1}{2}(A - B)\right) \Rightarrow I = I_{\max} \left\{ \sin\left(\frac{1}{2}(A - B)\right) \right\}^2$$



Two examples of superposed radiation:

Interference from refraction and reflection of thin films



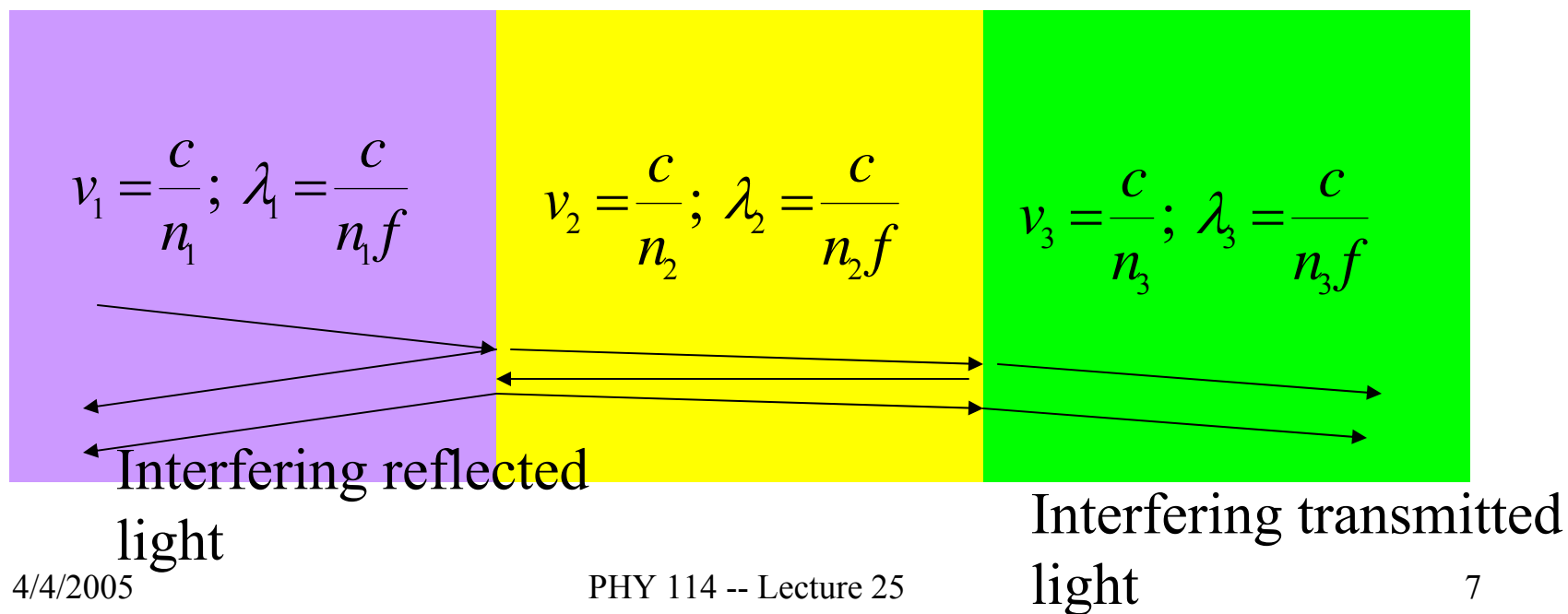
Young's double slit



## Interference in thin films

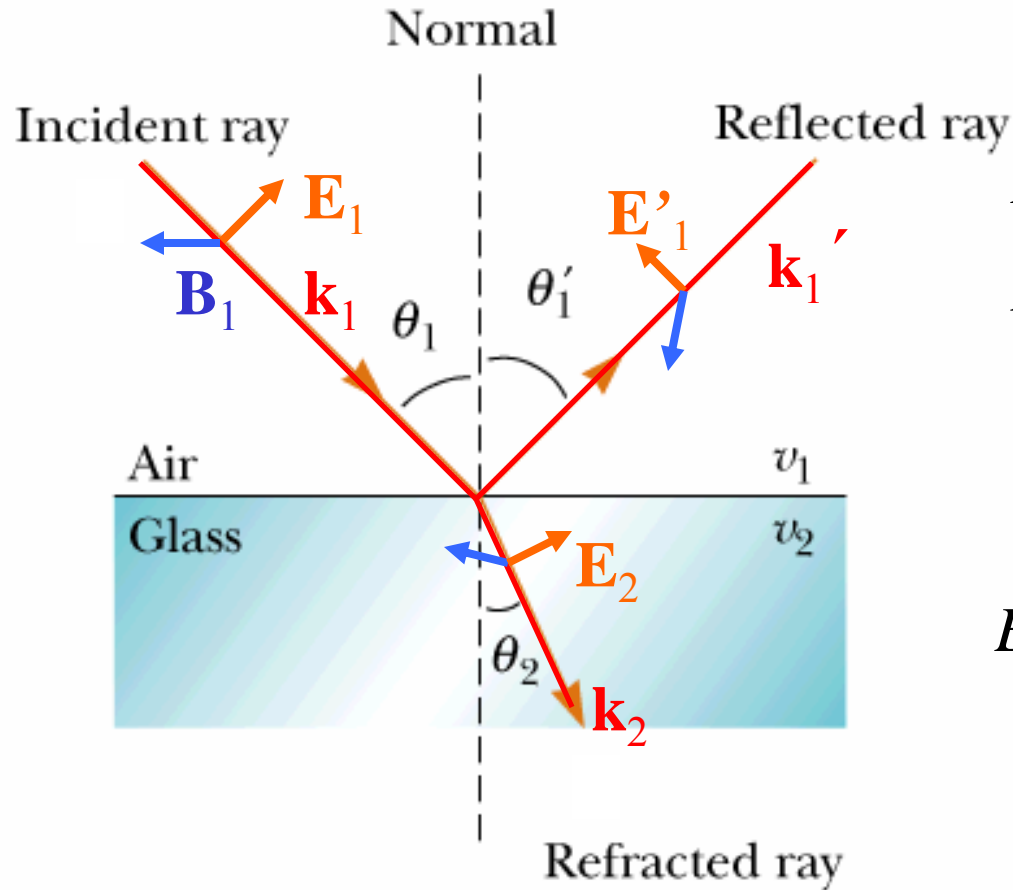
$$E_y(x, t) = E_{\max} \sin\left(\frac{2\pi}{\lambda}(x - vt) + \varphi\right)$$

$$v = \frac{c}{n}; \quad \lambda = \frac{c}{nf}$$



Interference between reflected waves:

Recall -- the behavior of a plane-polarized electromagnetic wave near the surface of two materials:



Periodic waves:

$$E_1 = E_{\max_1} \sin(\mathbf{k}_1 \cdot \mathbf{r} - \omega_1 t)$$

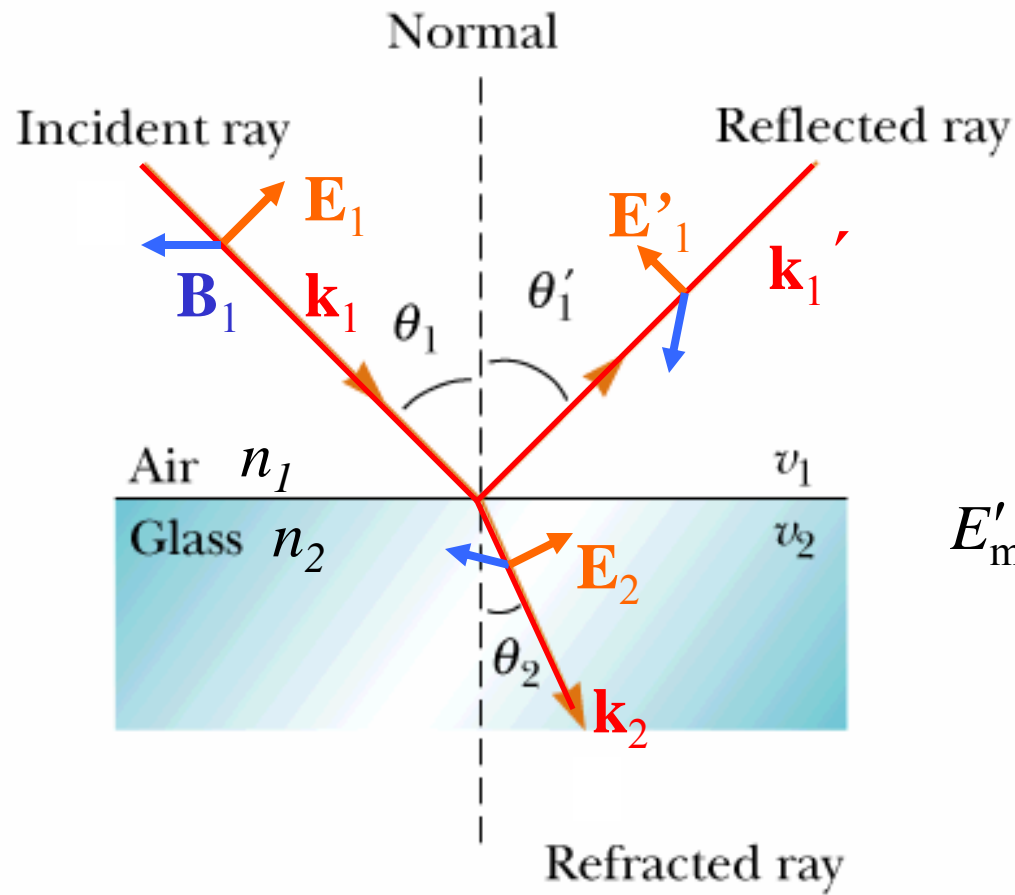
$$E_1' = E_{\max_1}' \sin(\mathbf{k}_1' \cdot \mathbf{r} - \omega_1' t)$$

$$\frac{\omega_1}{k_1} = \frac{\omega_1'}{k_1'} = v_1$$

$$E_2 = E_{\max_2} \sin(\mathbf{k}_2 \cdot \mathbf{r} - \omega_2 t)$$

$$\frac{\omega_2}{k_2} = v_2$$





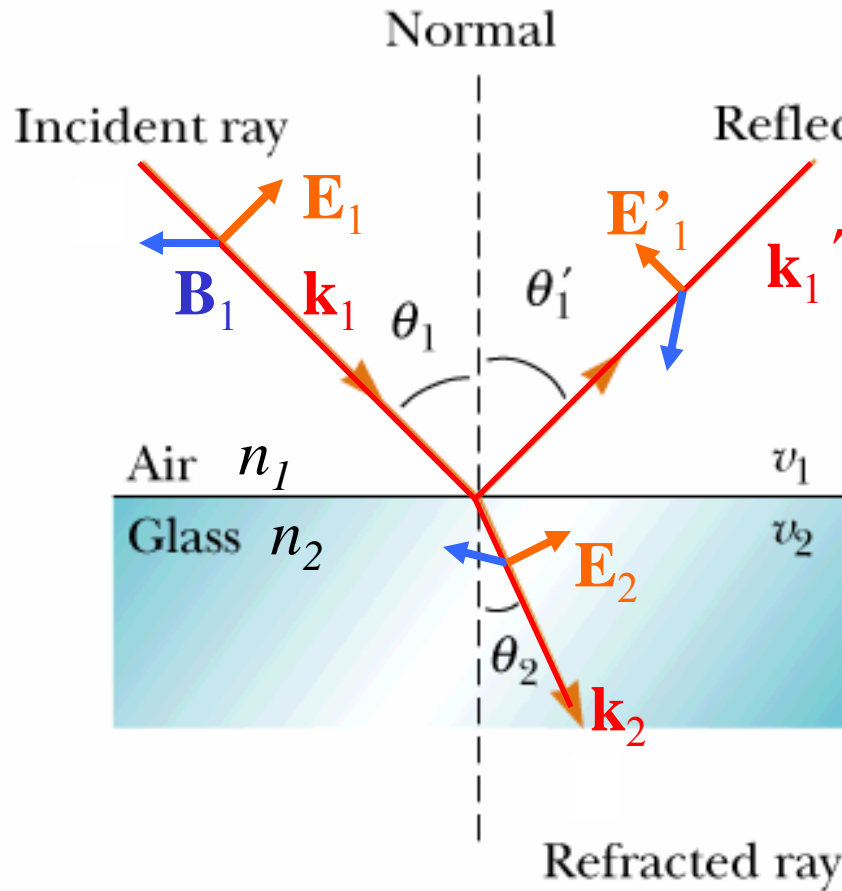
Matching electric and magnetic fields at boundary:

$$E'_{\max_1} = E_{\max_1} \frac{n_2 \cos \theta_1 - n_1 \cos \theta_2}{n_2 \cos \theta_1 + n_1 \cos \theta_2}$$

or

$$E'_{\max_1} = E_{\max_1} \frac{n_1 \cos \theta_1 - n_2 \cos \theta_2}{n_1 \cos \theta_1 + n_2 \cos \theta_2}$$

Plane waves reflected and refracted at surface:



Matching electric and magnetic fields at boundary:

For reflected waves:

$$E'_{\max_1} = E_{\max_1} \frac{n_2 \cos \theta_1 - n_1 \cos \theta_2}{n_2 \cos \theta_1 + n_1 \cos \theta_2}$$

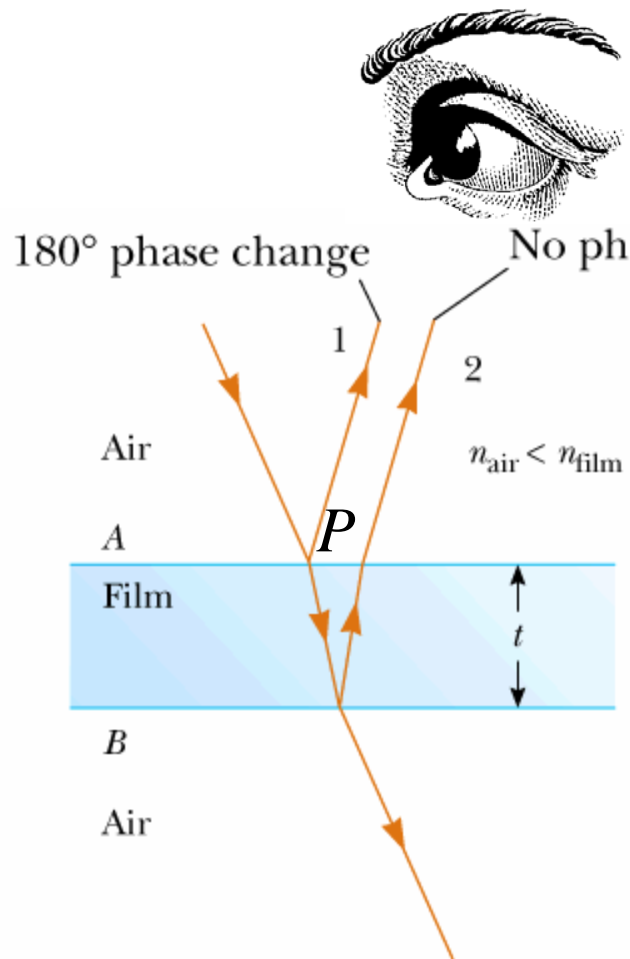
for E in plane of incidence

or

for E out of plane of incidence:

$$E'_{\max_1} = E_{\max_1} \frac{n_2 \cos \theta_2 - n_1 \cos \theta_1}{n_2 \cos \theta_2 + n_1 \cos \theta_1}$$

# Multiple refractions and reflections in a thin film



$$E(P, t) = \pm E_{\max} \sin\left(\frac{2\pi r_1}{\lambda_1} - 2\pi f t\right) \pm E'_{\max} \sin\left(\frac{2\pi r_2}{\lambda_2} - 2\pi f t\right)$$

$$\approx 2E_{\max} \left\{ \begin{matrix} \sin \\ \cos \end{matrix} \right\} \left( \frac{\pi(r_1 + r_2)}{\lambda_{\text{av}}} - 2\pi f t \right) \left\{ \begin{matrix} \cos \\ \sin \end{matrix} \right\} \left( \frac{\pi(r_2 - r_1)}{\lambda_2} \right)$$

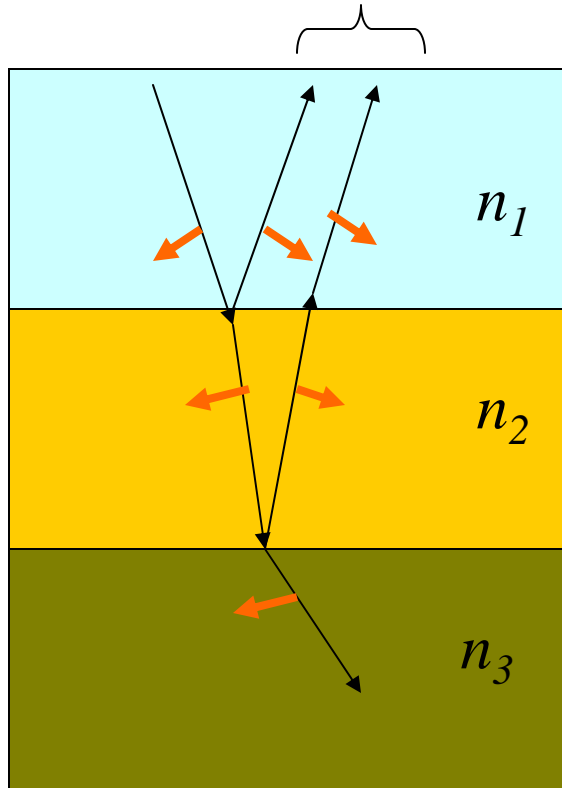
$$r_2 - r_1 \approx 2t$$

For  $n_2 > n_1$   $E_{\max_1} = -; E'_{\max_1} = +$

$$\Rightarrow \sin\left(\frac{\pi(2t)}{\lambda_2}\right) \Rightarrow \text{max at } 2nt = (m + \frac{1}{2})\lambda$$

$$\Rightarrow \text{min at } 2nt = m\lambda$$

Example of interference with “+”



$$n_1 < n_2 < n_3$$

For each surface with  $n_1 < n_2$

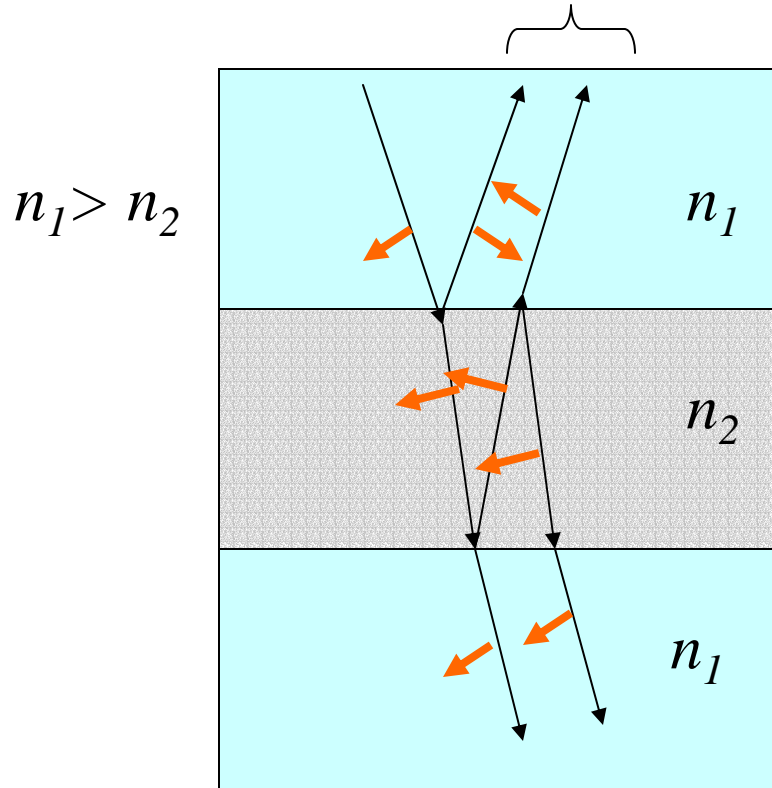
$$E_2 = -E_1 \text{ for reflected beam}$$

$$\Rightarrow I = I_{\max} \left\{ \cos\left(\frac{1}{2}(A - B)\right) \right\}^2$$

peaks at

$$\frac{1}{2}(A - B) \equiv \frac{\pi(r_2 - r_1)}{\lambda} = m\pi$$

Example of interference with “−”



$$\Rightarrow I = I_{\max} \left\{ \sin\left(\frac{1}{2}(A - B)\right) \right\}^2$$

peaks at

$$\frac{1}{2}(A - B) \equiv \frac{\pi(r_2 - r_1)}{\lambda} = \left(m + \frac{1}{2}\right)\pi$$

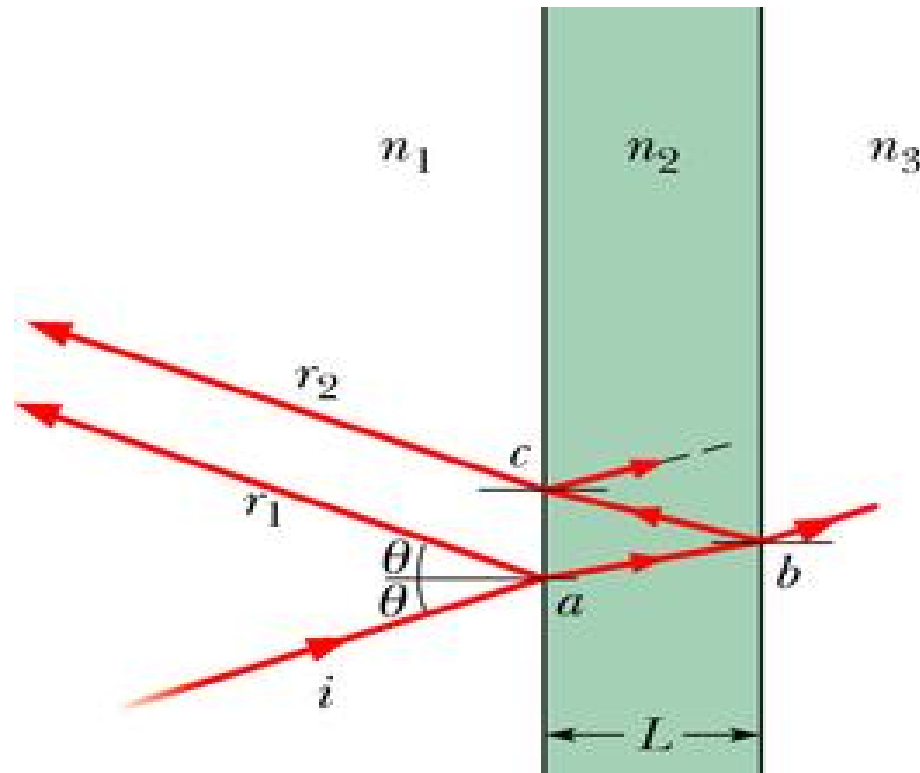
Example of interference with “+”

$$\Rightarrow I = I_{\max} \left\{ \cos\left(\frac{1}{2}(A - B)\right) \right\}^2$$

peaks at

$$\frac{1}{2}(A - B) \equiv \frac{\pi(r_2 - r_1)}{\lambda} = m\pi$$

## Summary



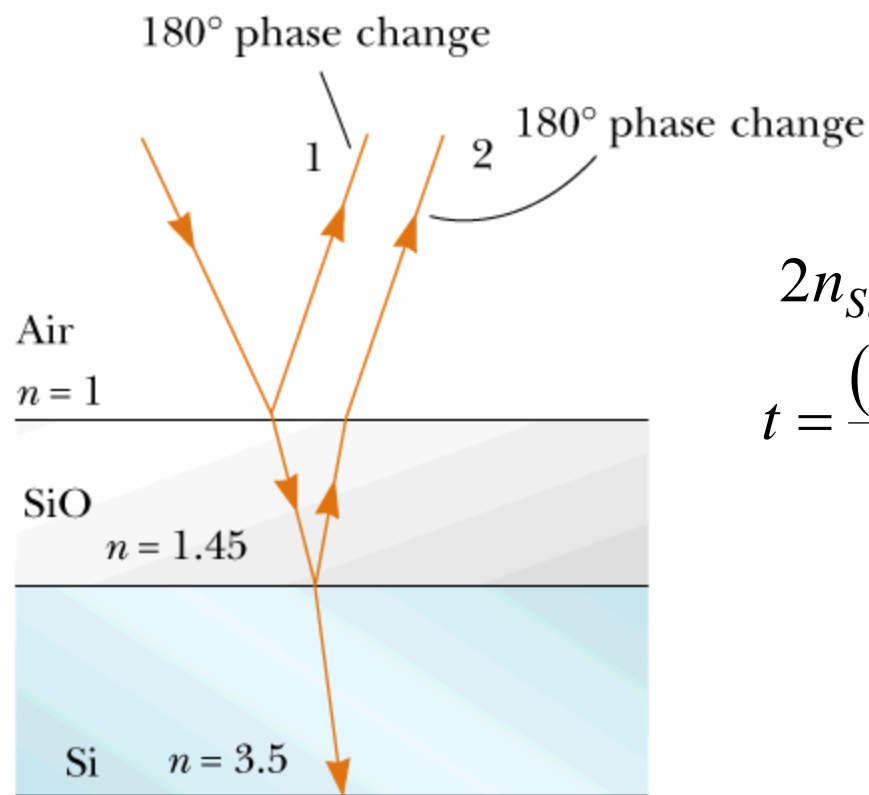
$$\varphi \approx 2\pi \frac{2L}{\lambda_2} = 2\pi \frac{2L}{\lambda} n_2$$

$$I = 4I_0 \cos^2\left(\frac{\varphi}{2}\right) \quad \Rightarrow \text{maxima at} \quad 2L = m \frac{\lambda}{n_2}$$

$$I = 4I_0 \sin^2\left(\frac{\varphi}{2}\right) \quad \Rightarrow \text{maxima at} \quad 2L = \left(m + \frac{1}{2}\right) \frac{\lambda}{n_2}$$

Example:

Suppose you want to prepare a surface so that it has minimal reflection such as in a solar cell where it is desirable to optimize refraction and minimize reflection at  $\lambda=550\text{nm}$ .



$$2n_{\text{SiO}}t = \left(m + \frac{1}{2}\right)\lambda$$
$$t = \frac{\left(m + \frac{1}{2}\right)\lambda}{2n_{\text{SiO}}} = \frac{\left(m + \frac{1}{2}\right)550 \text{ nm}}{2 \cdot 1.45}$$
$$= 94.8 \text{ nm (for } m = 0)$$

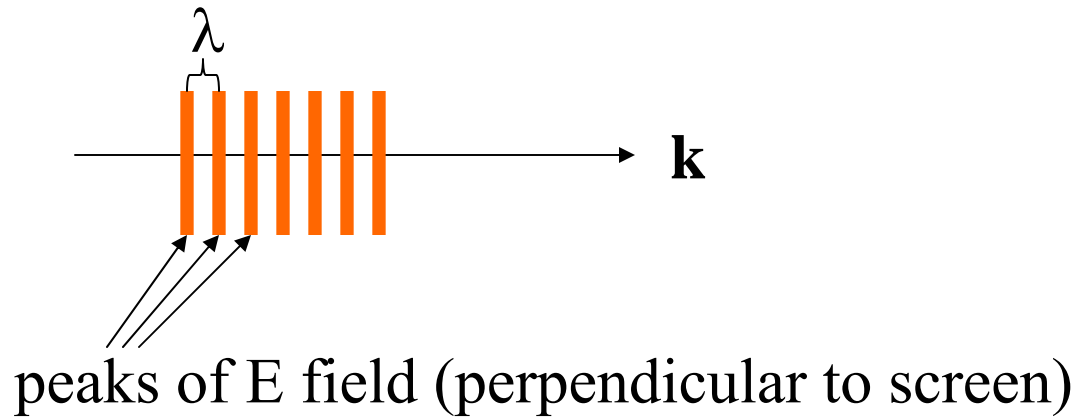
Example:

Suppose you see a rainbow pattern for oil on a pavement. What is the the approximate thickness of the oil in the red ( $\lambda=700\text{nm}$ ) region. Assume that  $n_{oil}=1.4$ .

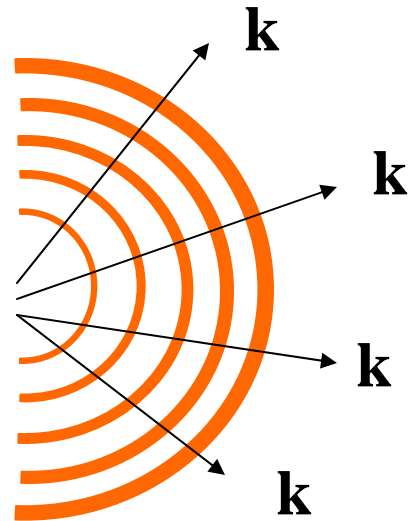
$$2n_{oil}t = (m + \frac{1}{2})\lambda$$
$$t = \frac{(m + \frac{1}{2})\lambda}{2n_{oil}} = \frac{(m + \frac{1}{2})700 \text{ nm}}{2 \cdot 1.4} = 125 \text{ nm}, 375 \text{ nm}, \text{ etc.}$$



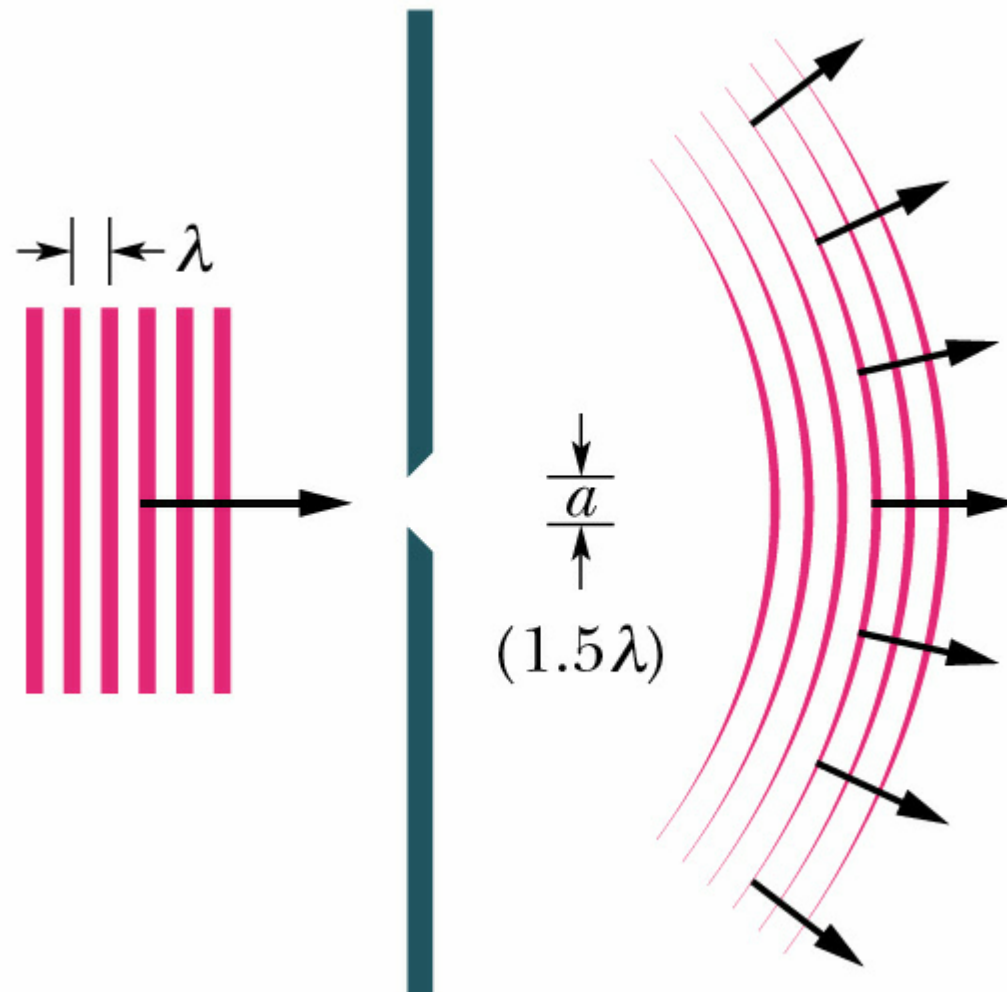
## Top view of plane EM wave



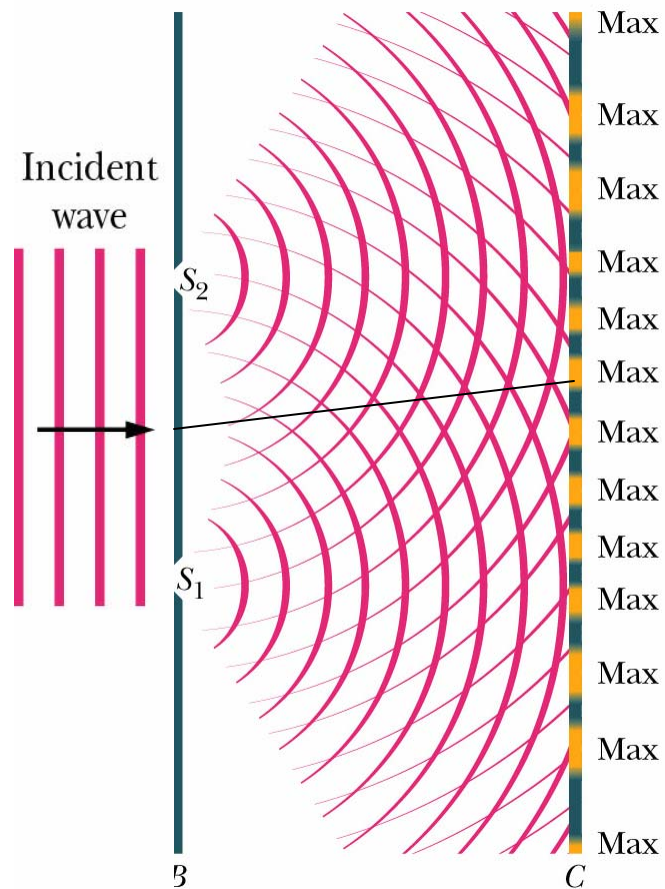
## Top view of spherical EM wave



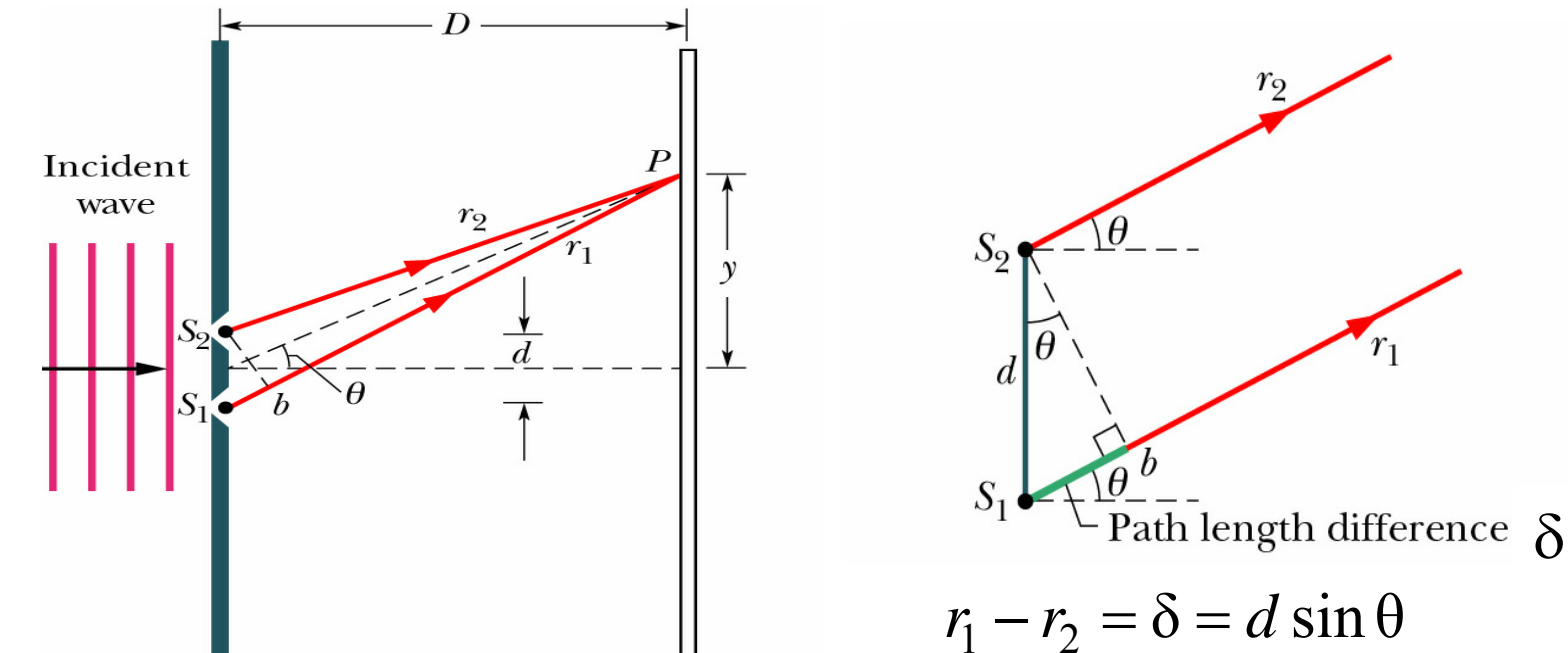
## Production of a spherical wave from a plane wave using a slit



## Interference of spherical waves in phase:



## Mathematical analysis of bright fringes:

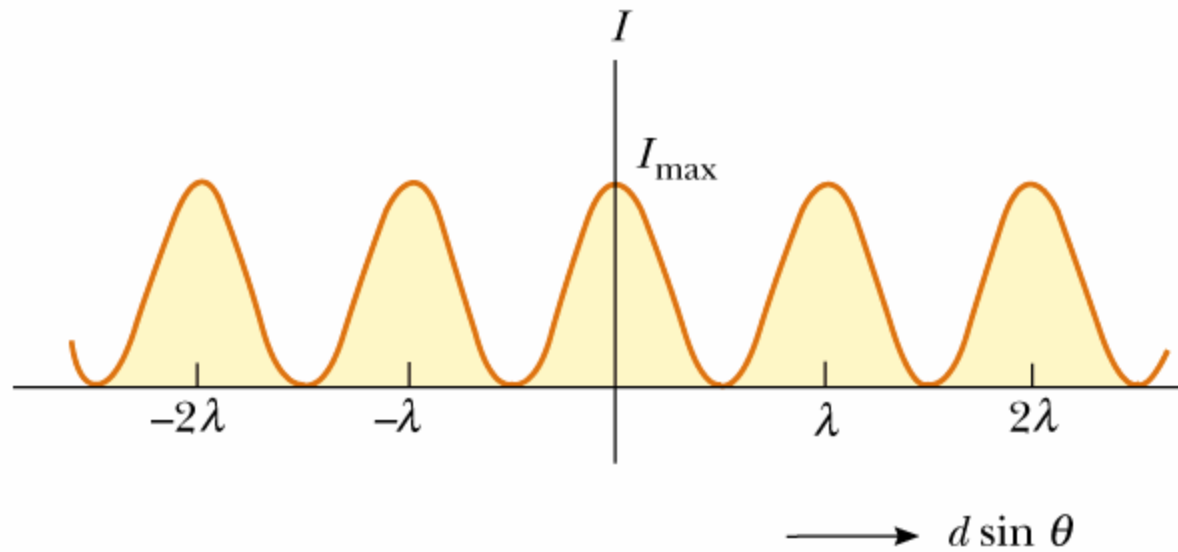


$$E(P, t) = E_{\max} \sin\left(\frac{2\pi r_1}{\lambda} - 2\pi f t\right) + E_{\max} \sin\left(\frac{2\pi r_2}{\lambda} - 2\pi f t\right)$$

$$= 2E_{\max} \sin\left(\frac{\pi(r_1 + r_2)}{\lambda} - 2\pi f t\right) \cos\left(\frac{\pi(r_1 - r_2)}{\lambda}\right)$$

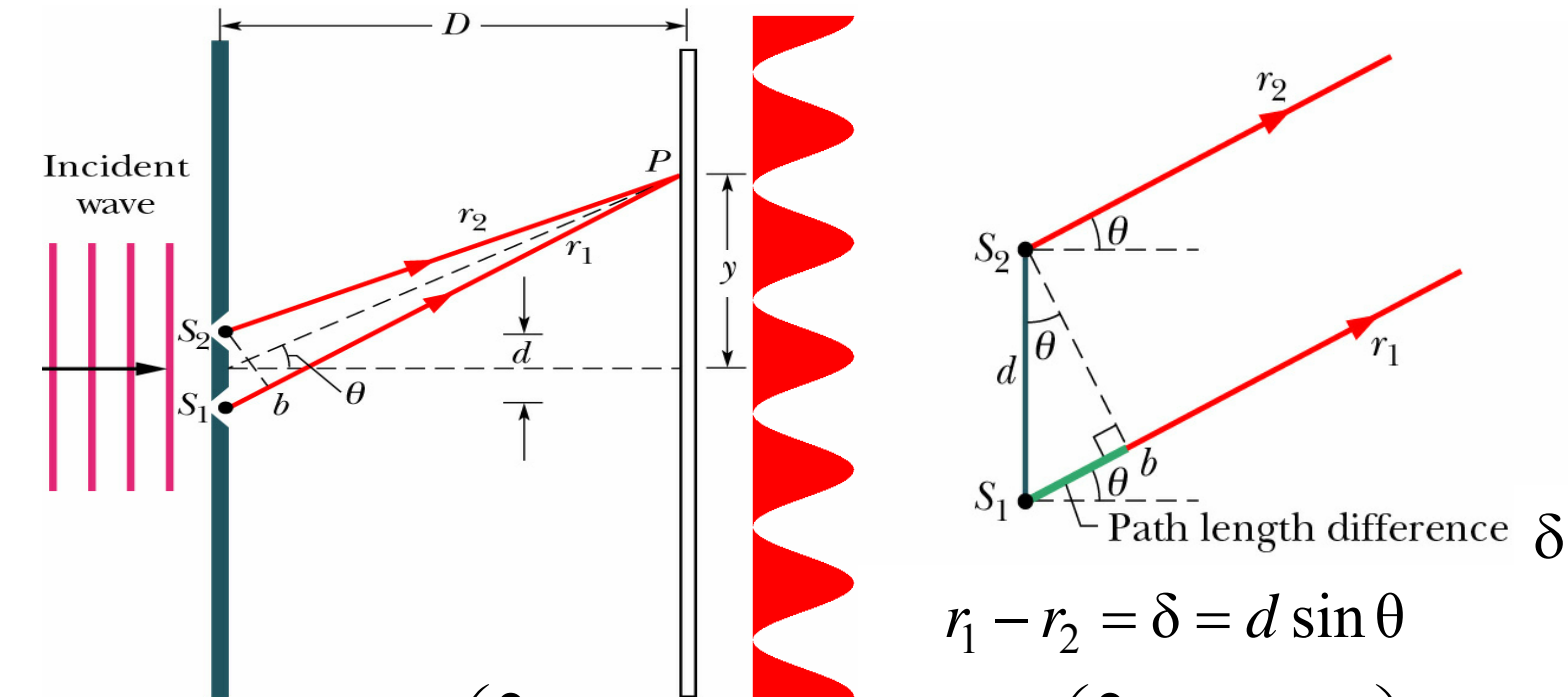
→ intensity maxima occur for  $\frac{\pi(r_1 - r_2)}{\lambda} = m\pi \Rightarrow d \sin \theta = m\lambda$

Intensity pattern at screen for double slit:



$$I = |\mathbf{S}|_{av} = \underbrace{\frac{4E_{\max}^2}{2\mu_0 c}}_{I_{\max}} \cos^2\left(\frac{\pi d \sin \theta}{\lambda}\right)$$

# Diffraction pattern from a plane wave incident on a double slit:



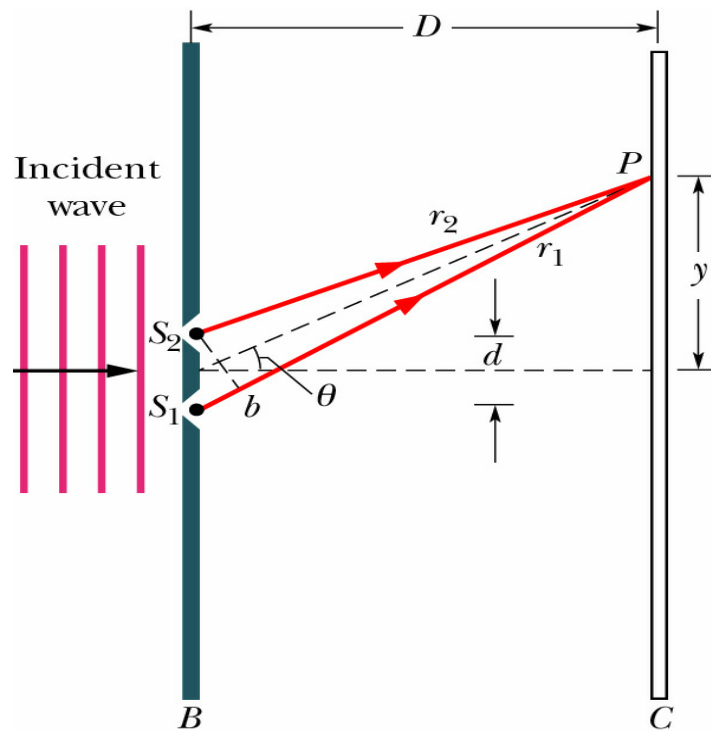
$$r_1 - r_2 = \delta = d \sin \theta$$

$$E(P, t) = E_{\max} \sin\left(\frac{2\pi r_1}{\lambda} - 2\pi f t\right) + E_{\max} \sin\left(\frac{2\pi r_2}{\lambda} - 2\pi f t\right)$$

$$= 2E_{\max} \sin\left(\frac{\pi(r_1 + r_2)}{\lambda} - 2\pi f t\right) \cos\left(\frac{\pi(r_1 - r_2)}{\lambda}\right)$$

→ intensity maxima occur for  $\frac{\pi(r_1 - r_2)}{\lambda} = m\pi \Rightarrow d \sin \theta = m\lambda$

## Summary of results:



Constructive interference :

$$d \sin \theta = m\lambda$$

Image on screen :

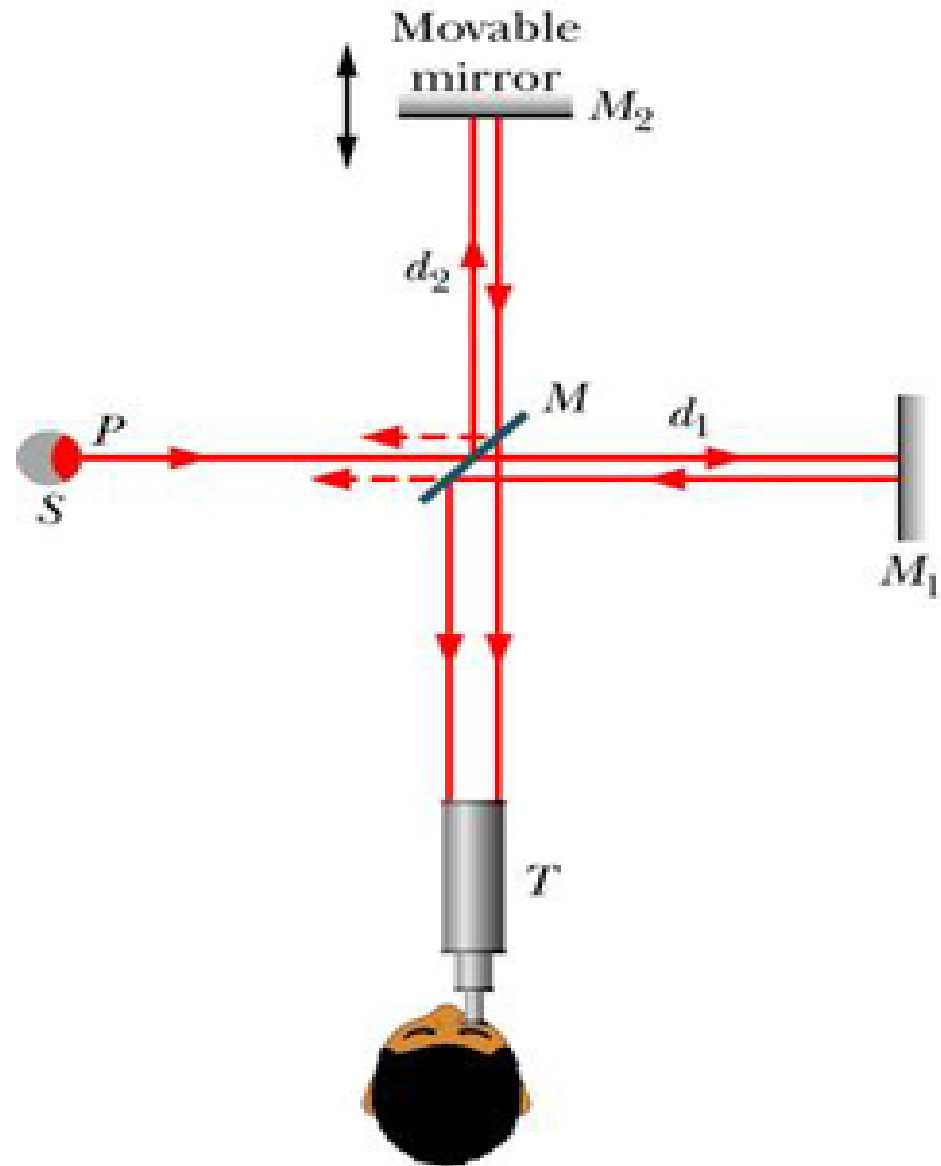
$$y \approx m\lambda \frac{D}{d}$$

## Michelson interferometer

$$\varphi = \frac{2\pi}{\lambda}(d_1 - d_2)$$

Intensity :

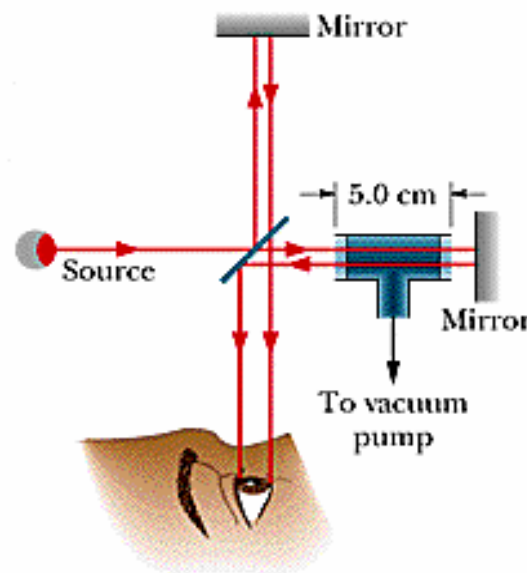
$$I = I_{\max} \sin^2\left(\frac{\varphi}{2}\right)$$





4. [HRW6 36.P.057.] An airtight chamber 5.0 cm long with glass windows is placed in one arm of a Michelson interferometer as indicated in Fig. 36-44. Light of wavelength  $\lambda = 500$  nm is used. When the air has been completely evacuated from the chamber, there has been a shift of 60 fringes. From these data, find the index of refraction of air at atmospheric pressure.

$$\phi = \frac{2\pi}{\lambda} 2L(n_{air} - 1)$$



## Online Quiz for Lecture 25

Interference phenomena in light waves -- Apr. 4, 2005

If you hold a compact disk up to a white light, you will see the colors separated. Is this phenomenon more like (A) an interference pattern produced by reflection from a thin transparent film

or

(B) an interference pattern produced by a grating.

Use the box to explain more details.